Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/533,077	LEE ET AL.
Examiner	Art Unit
Michel Graffeo	1614

	SEARCHED		
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
STN (See attached searh strategy)	4/14/2006	MG
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